D2 9

P-channel

G2c

Schematic diagram

D1 D1 D2 D2

Á₩APTIÎFÎ

S1 G1 S2 G2

Marking and pin assignment

SOP-8 top view

6 5

D19

N-channel

G1 0

# N and P-Channel Enhancement Mode Power MOSFET

#### Description

The PTI Î FÎ uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge . The SOP-8 package is universally preferred for all commercial industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

#### **General Features**

#### N-Channel

 $V_{DS} = 30V, I_D = 10A$   $R_{DS(ON)} < 20m\Omega @ V_{GS} = 4.5V$  $R_{DS(ON)} < 13.5m\Omega @ V_{GS} = 10V$ 

#### • P-Channel

 $V_{DS} = -30V, I_D = -9.1A$  $R_{DS(ON)} < 35m\Omega @ V_{GS} = -4.5V$  $R_{DS(ON)} < 20m\Omega @ V_{GS} = -10V$ 

- High power and current handing capability
- Lead free product is acquired
- Surface mount package

#### Application

- Battery protection
- Load switch
- Power management

#### Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
PT I Î FÎ	PT I Î FÎ	SOP-8	Ø330mm	12mm	2500 units

#### Absolute Maximum Ratings (T<sub>A</sub>=25℃unless otherwise noted)

Paramet	Symbol	N-Channel	P-Channel	Unit		
Drain-Source Voltage		V <sub>DS</sub>	30	-30	V	
Gate-Source Voltage		V <sub>GS</sub>	±20	±20	V	
Continuous Drain Current	T <sub>A</sub> =25℃	- I <sub>D</sub>	10	-9.1	٨	
Continuous Drain Current	T <sub>A</sub> =70℃		7.9	-7.2	A	
Pulsed Drain Current (Note 1)		I <sub>DM</sub>	30	-30	А	
Maximum Power Dissipation T <sub>A</sub> =25°C		PD	2.5	2.5	W	
Operating Junction and Storage Temperature Range		T <sub>J</sub> ,T <sub>STG</sub>	-55 To 150	-55 To 150	°C	



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#### **Thermal Characteristic**

Thermal Resistance, Junction-to-Ambient (Note2)	P	N-Ch	50	°C/W	
	R <sub>0JA</sub>	P-Ch	50	C/VV	

#### N-CH Electrical Characteristics (T<sub>A</sub>=25<sup>°</sup>C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Мах	Unit
Off Characteristics	·		•			
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250µA	30	33	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =30V,V <sub>GS</sub> =0V	-	-	1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	$V_{GS}$ =±20V, $V_{DS}$ =0V	-	-	±100	nA
On Characteristics (Note 3)	·		•			
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$	1	1.6	3	V
Drain-Source On-State Resistance	P	V <sub>GS</sub> =10V, I <sub>D</sub> =10A	-	7.5	13.5	mΩ
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	$V_{GS}$ =4.5V, $I_{D}$ =5A	-	11	20	mΩ
Forward Transconductance	<b>g</b> fs	V <sub>DS</sub> =5V,I <sub>D</sub> =10A	15	-	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C <sub>lss</sub>		-	1550	-	PF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> =15V,V <sub>GS</sub> =0V, F=1.0MHz	-	300	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>		-	180	-	PF
Switching Characteristics (Note 4)	·		•			
Turn-on Delay Time	t <sub>d(on)</sub>		-	30	-	nS
Turn-on Rise Time	tr	$V_{DD}=25V,I_{D}=1A$	-	20	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =10V, $R_{GEN}$ =6 $\Omega$	-	100	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	80	-	nS
Total Gate Charge	Qg		-	13	-	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ =15V,I <sub>D</sub> =10A,	-	5.5	-	nC
Gate-Drain Charge	Q <sub>gd</sub>	V <sub>GS</sub> =4.5V	-	3.5	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =6A	-	0.8	1.2	V

# P-CH Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min		Мах	Unit
Off Characteristics	····					
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	BV <sub>DSS</sub> V <sub>GS</sub> =0V I <sub>D</sub> =-250µA		-33	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-30V,V <sub>GS</sub> =0V	-	-	-1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	$V_{GS}$ =±20V, $V_{DS}$ =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS}=V_{GS}$ , $I_{D}=-250\mu A$	-1	-1.5	-3	V
		V <sub>GS</sub> =-10V, I <sub>D</sub> =-9.1A	-	15	20	mΩ
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-5A	-	21	35	mΩ
Forward Transconductance	<b>G</b> FS	V <sub>DS</sub> =-15V,I <sub>D</sub> =-9.1A	10	-	-	S
Dynamic Characteristics (Note4)						
Input Capacitance	C <sub>lss</sub>		-	1600	-	PF
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> =-15V,V <sub>GS</sub> =0V, F=1.0MHz	-	350	-	PF
Reverse Transfer Capacitance	Crss	F=1.0MHZ	-	300	-	PF
Switching Characteristics (Note 4)	····		÷			
Turn-on Delay Time	t <sub>d(on)</sub>		-	10	-	nS
Turn-on Rise Time	tr	V <sub>DD</sub> =-15V, ID=-1A,	-	15	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =-10V, $R_{GEN}$ =6 $\Omega$	-	110	-	nS
Turn-Off Fall Time	t <sub>f</sub>		-	70	-	nS
Total Gate Charge	Qg		-	30	-	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>DS</sub> =-15V,I <sub>D</sub> =-9.1A V <sub>GS</sub> =-10V	-	5.5	-	nC
Gate-Drain Charge	Q <sub>gd</sub>	VGS10V	-	8	-	nC
Drain-Source Diode Characteristics	<b>i</b>		•			
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =-6A	-	-	-1.2	V

Notes:

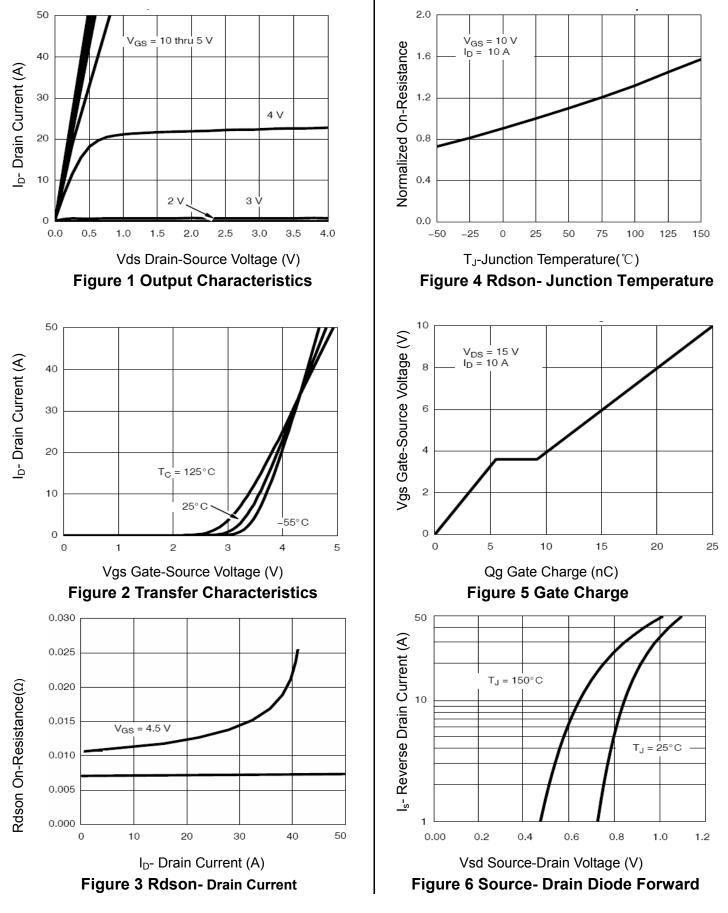
1. Repetitive Rating: Pulse width limited by maximum junction temperature.

**2.** Surface Mounted on FR4 Board,  $t \le 10$  sec.

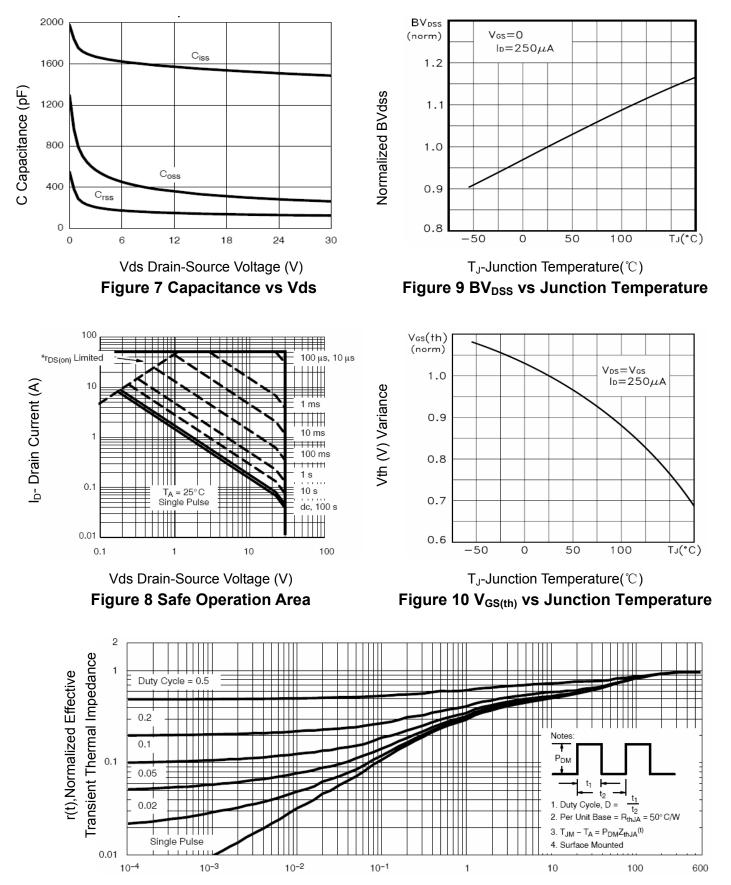
**3.** Pulse Test: Pulse Width  $\leq$  300µs, Duty Cycle  $\leq$  2%.

4. Guaranteed by design, not subject to production

## N- Channel Typical Electrical and Thermal Characteristics (Curves)







Square Wave Pluse Duration(sec) Figure 11 Normalized Maximum Transient Thermal Impedance

### P-Channel Typical Electrical and Thermal Characteristics

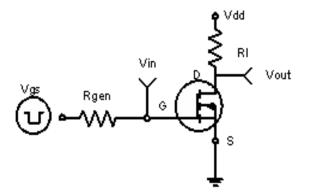
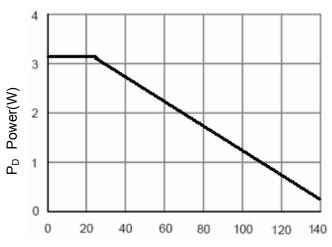
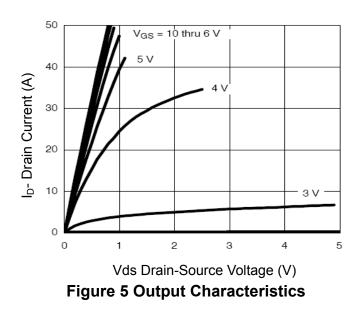
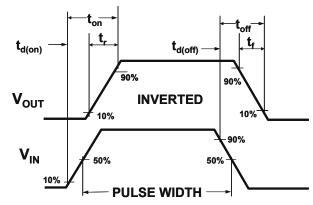


Figure 1:Switching Test Circuit

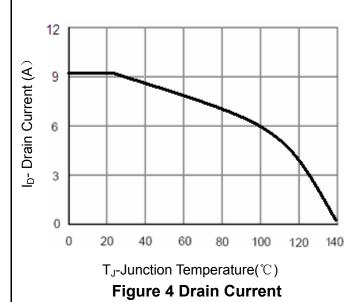


T<sub>J</sub>-Junction Temperature(℃) Figure 3 Power Dissipation







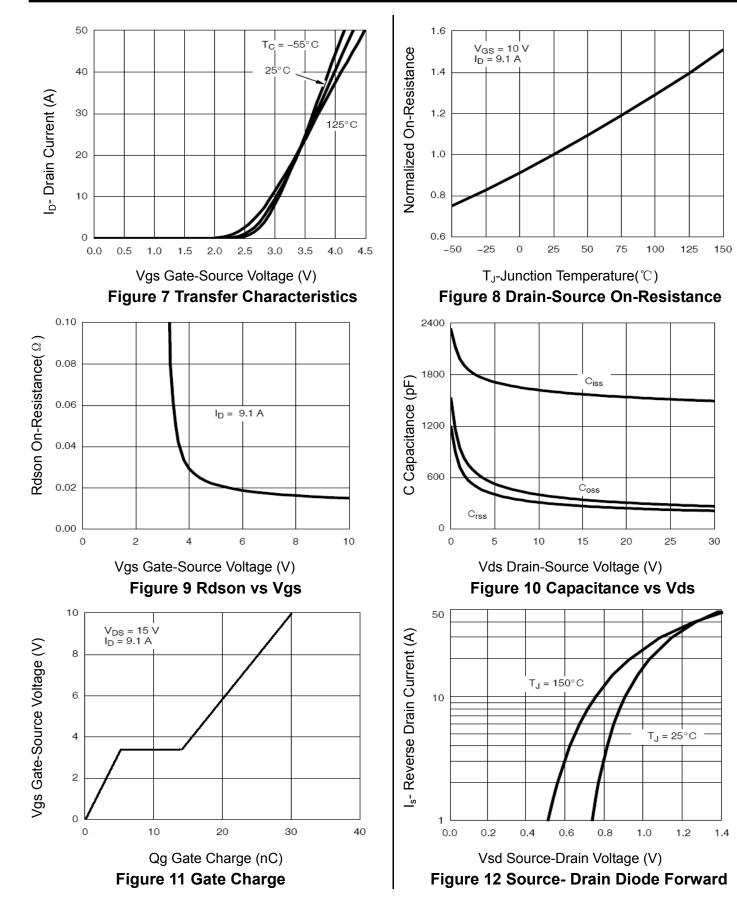


0.040 0.035 Rdson On-Resistance(  $\Omega$  ) 0.030 V<sub>GS</sub> = 4.5 V 0.025 0.020 V<sub>GS</sub> = 10 V 0.015 0.010 0.005 0.000 10 20 30 40 0 50 I<sub>D</sub>- Drain Current (A)

Figure 6 Drain-Source On-Resistance

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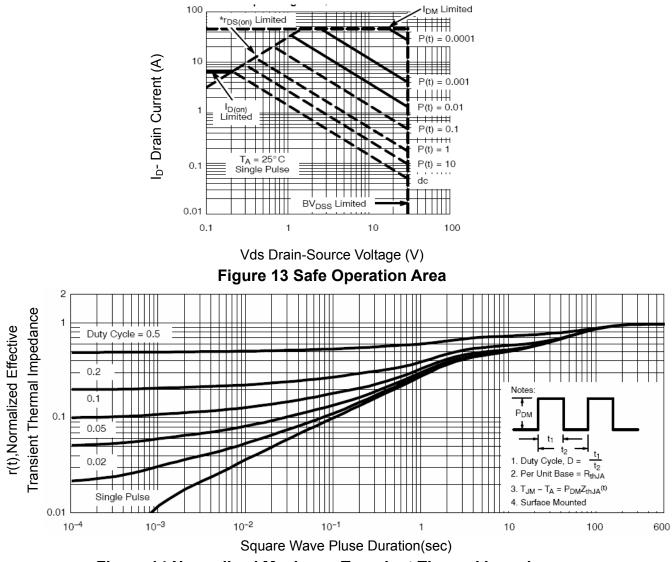
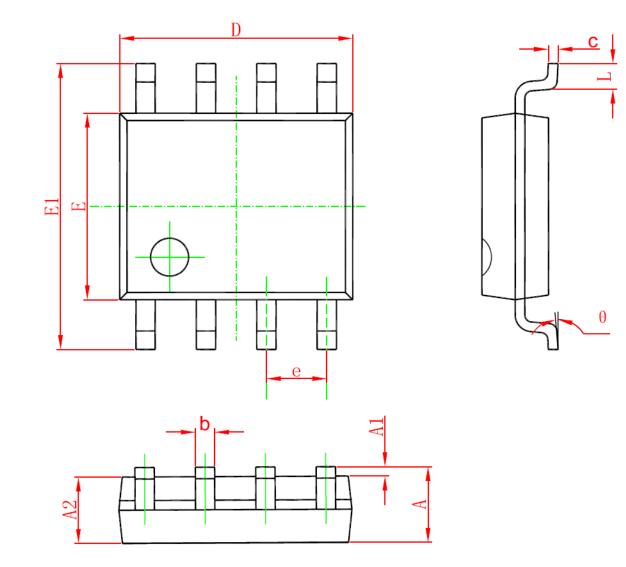


Figure 14 Normalized Maximum Transient Thermal Impedance

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# **SOP-8 Package Information**



Symbol	Dimensions Ir	n Millimeters	Dimensions In Inches		
	Min	Max	Min	Max	
A	1. 350	1. 750	0. 053	0. 069	
A1	0. 100	0. 250	0.004	0. 010	
A2	1.350	1.550	0. 053	0. 061	
b	0. 330	0. 510	0.013	0. 020	
С	0. 170	0. 250	0.006	0. 010	
D	4. 700	5. 100	0. 185	0. 200	
E	3.800	4.000	0. 150	0. 157	
E1	5. 800	6. 200	0. 228	0. 244	
е	1. 270 (BSC)		0. 050 (BSC)		
L	0. 400	1.270	0.016	0. 050	
θ	0°	8°	0°	8°	

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